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Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of [Embedded - Microprocessors](#)

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details

Product Status	Obsolete
Core Processor	PowerPC e300c3
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	267MHz
Co-Processors/DSP	-
RAM Controllers	DDR, DDR2
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (2)
SATA	-
USB	USB 2.0 + PHY (1)
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	516-BBGA Exposed Pad
Supplier Device Package	516-TEPBGA (27x27)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mpc8313vradb

1 Overview

The MPC8313E incorporates the e300c3 core, which includes 16 Kbytes of L1 instruction and data caches and on-chip memory management units (MMUs). The MPC8313E has interfaces to dual enhanced three-speed 10/100/1000 Mbps Ethernet controllers, a DDR1/DDR2 SDRAM memory controller, an enhanced local bus controller, a 32-bit PCI controller, a dedicated security engine, a USB 2.0 dual-role controller and an on-chip high-speed PHY, a programmable interrupt controller, dual I²C controllers, a 4-channel DMA controller, and a general-purpose I/O port. This figure shows a block diagram of the MPC8313E.



Figure 1. MPC8313E Block Diagram

The MPC8313E security engine (SEC 2.2) allows CPU-intensive cryptographic operations to be offloaded from the main CPU core. The security-processing accelerator provides hardware acceleration for the DES, 3DES, AES, SHA-1, and MD-5 algorithms.

1.1 MPC8313E Features

The following features are supported in the MPC8313E:

- Embedded PowerPC™ e300 processor core built on Power Architecture™ technology; operates at up to 333 MHz.
- High-performance, low-power, and cost-effective host processor
- DDR1/DDR2 memory controller—one 16-/32-bit interface at up to 333 MHz supporting both DDR1 and DDR2
- 16-Kbyte instruction cache and 16-Kbyte data cache, a floating point unit, and two integer units
- Peripheral interfaces such as 32-bit PCI interface with up to 66-MHz operation, 16-bit enhanced local bus interface with up to 66-MHz operation, and USB 2.0 (high speed) with an on-chip PHY.
- Security engine provides acceleration for control and data plane security protocols
- Power management controller for low-power consumption
- High degree of software compatibility with previous-generation PowerQUICC processor-based designs for backward compatibility and easier software migration

1.2 Serial Interfaces

The following interfaces are supported in the MPC8313E: dual UART, dual I²C, and an SPI interface.

1.3 Security Engine

The security engine is optimized to handle all the algorithms associated with IPSec, IEEE Std 802.11i®, and iSCSI. The security engine contains one crypto-channel, a controller, and a set of crypto execution units (EUs). The execution units are as follows:

- Data encryption standard execution unit (DEU), supporting DES and 3DES
- Advanced encryption standard unit (AESU), supporting AES
- Message digest execution unit (MDEU), supporting MD5, SHA1, SHA-224, SHA-256, and HMAC with any algorithm
- One crypto-channel supporting multi-command descriptor chains

1.4 DDR Memory Controller

The MPC8313E DDR1/DDR2 memory controller includes the following features:

- Single 16- or 32-bit interface supporting both DDR1 and DDR2 SDRAM
- Support for up to 333 MHz
- Support for two physical banks (chip selects), each bank independently addressable
- 64-Mbit to 2-Gbit (for DDR1) and to 4-Gbit (for DDR2) devices with x8/x16/x32 data ports (no direct x4 support)
- Support for one 16-bit device or two 8-bit devices on a 16-bit bus, or one 32-bit device or two 16-bit devices on a 32-bit bus
- Support for up to 16 simultaneous open pages
- Supports auto refresh
- On-the-fly power management using CKE
- 1.8-/2.5-V SSTL2 compatible I/O

1.5 PCI Controller

The MPC8313E PCI controller includes the following features:

- PCI specification revision 2.3 compatible
- Single 32-bit data PCI interface operates at up to 66 MHz
- PCI 3.3-V compatible (not 5-V compatible)
- Support for host and agent modes
- On-chip arbitration, supporting three external masters on PCI
- Selectable hardware-enforced coherency

3 Power Characteristics

The estimated typical power dissipation, not including I/O supply power, for this family of MPC8313E devices is shown in this table. [Table 5](#) shows the estimated typical I/O power dissipation.

Table 4. MPC8313E Power Dissipation¹

Core Frequency (MHz)	CSB Frequency (MHz)	Typical ²	Maximum for Rev. 1.0 Silicon ³	Maximum for Rev. 2.x or Later Silicon ³	Unit
333	167	820	1020	1200	mW
400	133	820	1020	1200	mW

Note:

1. The values do not include I/O supply power or AV_{DD} , but do include core, USB PLL, and a portion of SerDes digital power (not including $XCOREV_{DD}$, $XPADV_{DD}$, or $SDAV_{DD}$, which all have dedicated power supplies for the SerDes PHY).
2. Typical power is based on a voltage of $V_{DD} = 1.05$ V and an artificial smoker test running at room temperature.
3. Maximum power is based on a voltage of $V_{DD} = 1.05$ V, a junction temperature of $T_J = 105^\circ\text{C}$, and an artificial smoker test.

This table describes a typical scenario where blocks with the stated percentage of utilization and impedances consume the amount of power described.

Table 5. MPC8313E Typical I/O Power Dissipation

Interface	Parameter	GV_{DD} (1.8 V)	GV_{DD} (2.5 V)	NV_{DD} (3.3 V)	$LV_{DDA}/$ LV_{DDB} (3.3 V)	$LV_{DDA}/$ LV_{DDB} (2.5 V)	LV_{DD} (3.3 V)	Unit	Comments
DDR 1, 60% utilization, 50% read/write $R_s = 22 \Omega$ $R_t = 50 \Omega$ single pair of clock capacitive load: data = 8 pF, control address = 8 pF, clock = 8 pF	333 MHz, 32 bits	—	0.355	—	—	—	—	W	—
	266 MHz, 32 bits	—	0.323	—	—	—	—	W	—
DDR 2, 60% utilization, 50% read/write $R_s = 22 \Omega$ $R_t = 75 \Omega$ single pair of clock capacitive load: data = 8 pF, control address = 8 pF, clock = 8 pF	333 MHz, 32 bits	0.266	—	—	—	—	—	W	—
	266 MHz, 32 bits	0.246	—	—	—	—	—	W	—
PCI I/O load = 50 pF	33 MHz	—	—	0.120	—	—	—	W	—
	66 MHz	—	—	0.249	—	—	—	W	—
Local bus I/O load = 20 pF	66 MHz	—	—	—	—	—	0.056	W	—
	50 MHz	—	—	—	—	—	0.040	W	—
TSEC I/O load = 20 pF	MII, 25 MHz	—	—	—	0.008	—	—	W	Multiple by number of interface used
	RGMII, 125 MHz	—	—	—	0.078	0.044	—	W	

6.1 DDR and DDR2 SDRAM DC Electrical Characteristics

This table provides the recommended operating conditions for the DDR2 SDRAM component(s) when $GV_{DD}(typ) = 1.8\text{ V}$.

Table 12. DDR2 SDRAM DC Electrical Characteristics for $GV_{DD}(typ) = 1.8\text{ V}$

Parameter/Condition	Symbol	Min	Max	Unit	Note
I/O supply voltage	GV_{DD}	1.7	1.9	V	1
I/O reference voltage	MV_{REF}	$0.49 \times GV_{DD}$	$0.51 \times GV_{DD}$	V	2
I/O termination voltage	V_{TT}	$MV_{REF} - 0.04$	$MV_{REF} + 0.04$	V	3
Input high voltage	V_{IH}	$MV_{REF} + 0.125$	$GV_{DD} + 0.3$	V	—
Input low voltage	V_{IL}	-0.3	$MV_{REF} - 0.125$	V	—
Output leakage current	I_{OZ}	-9.9	9.9	μA	4
Output high current ($V_{OUT} = 1.420\text{ V}$)	I_{OH}	-13.4	—	mA	—
Output low current ($V_{OUT} = 0.280\text{ V}$)	I_{OL}	13.4	—	mA	—

Notes:

- GV_{DD} is expected to be within 50 mV of the DRAM GV_{DD} at all times.
- MV_{REF} is expected to be equal to $0.5 \times GV_{DD}$, and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on MV_{REF} may not exceed $\pm 2\%$ of the DC value.
- V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV_{REF} . This rail should track variations in the DC level of MV_{REF} .
- Output leakage is measured with all outputs disabled, $0\text{ V} \leq V_{OUT} \leq GV_{DD}$.

This table provides the DDR2 capacitance when $GV_{DD}(typ) = 1.8\text{ V}$.

Table 13. DDR2 SDRAM Capacitance for $GV_{DD}(typ) = 1.8\text{ V}$

Parameter/Condition	Symbol	Min	Max	Unit	Note
Input/output capacitance: DQ, DQS, $\overline{\text{DQS}}$	C_{IO}	6	8	pF	1
Delta input/output capacitance: DQ, DQS, $\overline{\text{DQS}}$	C_{DIO}	—	0.5	pF	1

Note:

- This parameter is sampled. $GV_{DD} = 1.8\text{ V} \pm 0.090\text{ V}$, $f = 1\text{ MHz}$, $T_A = 25^\circ\text{C}$, $V_{OUT} = GV_{DD}/2$, V_{OUT} (peak-to-peak) = 0.2 V.

This table provides the recommended operating conditions for the DDR SDRAM component(s) when $GV_{DD}(typ) = 2.5\text{ V}$.

Table 14. DDR SDRAM DC Electrical Characteristics for $GV_{DD}(typ) = 2.5\text{ V}$

Parameter/Condition	Symbol	Min	Max	Unit	Note
I/O supply voltage	GV_{DD}	2.3	2.7	V	1
I/O reference voltage	MV_{REF}	$0.49 \times GV_{DD}$	$0.51 \times GV_{DD}$	V	2
I/O termination voltage	V_{TT}	$MV_{REF} - 0.04$	$MV_{REF} + 0.04$	V	3
Input high voltage	V_{IH}	$MV_{REF} + 0.15$	$GV_{DD} + 0.3$	V	—
Input low voltage	V_{IL}	-0.3	$MV_{REF} - 0.15$	V	—

8.2.1.4 RMI Receive AC Timing Specifications

This table provides the RMI receive AC timing specifications.

Table 29. RMI Receive AC Timing Specifications

At recommended operating conditions with NV_{DD} of $3.3\text{ V} \pm 0.3\text{ V}$.

Parameter/Condition	Symbol ¹	Min	Typ	Max	Unit
REF_CLK clock period	t_{RMX}	—	20	—	ns
REF_CLK duty cycle	t_{RMXH}/t_{RMX}	35	—	65	%
RXD[1:0], CRS_DV, RX_ER setup time to REF_CLK	$t_{RMRDVKH}$	4.0	—	—	ns
RXD[1:0], CRS_DV, RX_ER hold time to REF_CLK	$t_{RMRDXKH}$	2.0	—	—	ns
REF_CLK clock rise $V_{IL}(\text{min})$ to $V_{IH}(\text{max})$	t_{RMXR}	1.0	—	4.0	ns
REF_CLK clock fall time $V_{IH}(\text{max})$ to $V_{IL}(\text{min})$	t_{RMXF}	1.0	—	4.0	ns

Note:

- The symbols used for timing specifications follow the pattern of $t_{(\text{first three letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$ for inputs and $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$ for outputs. For example, $t_{RMRDVKH}$ symbolizes RMI receive timing (RMR) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{RMX} clock reference (K) going to the high (H) state or setup time. Also, $t_{RMRDXKL}$ symbolizes RMI receive timing (RMR) with respect to the time data input signals (D) went invalid (X) relative to the t_{RMX} clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{RMX} represents the RMI (RM) reference (X) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

This table provides the AC test load.

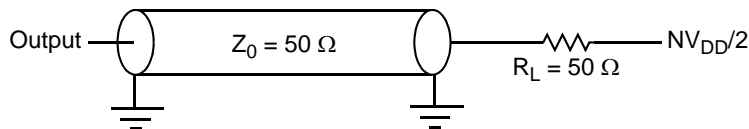


Figure 12. AC Test Load

This table shows the RMI receive AC timing diagram.

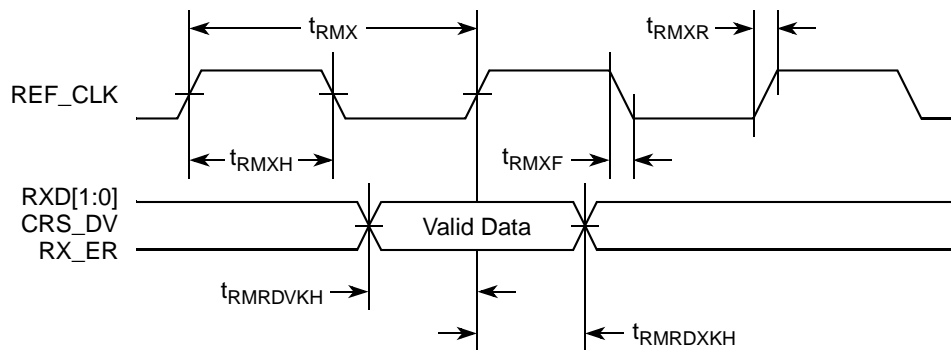


Figure 13. RMI Receive AC Timing Diagram

Table 33. SGMII DC Receiver Electrical Characteristics (continued)

Parameter	Symbol	Min	Typ	Max	Unit	Note
Common mode input voltage	V_{CM}	—	$V_{XCOREVSS}$	—	V	4

Notes:

1. Input must be externally AC-coupled.
2. $V_{RX_DIFFp-p}$ is also referred to as peak to peak input differential voltage
3. V_{CM_ACp-p} is also referred to as peak to peak AC common mode voltage.
4. On-chip termination to $XCOREV_{SS}$.

8.3.4 SGMII AC Timing Specifications

This section describes the SGMII transmit and receive AC timing specifications. Transmitter and receiver characteristics are measured at the transmitter outputs (TX[n] and $\overline{TX}[n]$) or at the receiver inputs (RX[n] and $\overline{RX}[n]$) as depicted in Figure 18, respectively.

8.3.4.1 SGMII Transmit AC Timing Specifications

This table provides the SGMII transmit AC timing targets. A source synchronous clock is not provided.

Table 34. SGMII Transmit AC Timing Specifications

At recommended operating conditions with $XCOREV_{DD} = 1.0\text{ V} \pm 5\%$.

Parameter	Symbol	Min	Typ	Max	Unit	Note
Deterministic jitter	JD	—	—	0.17	UI p-p	
Total jitter	JT	—	—	0.35	UI p-p	
Unit interval	UI	799.92	800	800.08	ps	1
V_{OD} fall time (80%–20%)	t _{fall}	50	—	120	ps	
V_{OD} rise time (20%–80%)	t _{rise}	50	—	120	ps	

Note:

1. Each UI is 800 ps \pm 100 ppm.

8.3.4.2 SGMII Receive AC Timing Specifications

This table provides the SGMII receive AC timing specifications. Source synchronous clocking is not supported. Clock is recovered from the data. Figure 17 shows the SGMII receiver input compliance mask eye diagram.

Table 35. SGMII Receive AC Timing Specifications

At recommended operating conditions with $XCOREV_{DD} = 1.0\text{ V} \pm 5\%$.

Parameter	Symbol	Min	Typ	Max	Unit	Note
Deterministic jitter tolerance	JD	0.37	—	—	UI p-p	1
Combined deterministic and random jitter tolerance	JDR	0.55	—	—	UI p-p	1
Sinusoidal jitter tolerance	JSIN	0.1	—	—	UI p-p	1

of the differential pair must have a single-ended swing less than 800 mV and greater than 200 mV. This requirement is the same for both external DC-coupled or AC-coupled connection.

- For external DC-coupled connection, as described in [Section 9.2.1, “SerDes Reference Clock Receiver Characteristics,”](#) the maximum average current requirements sets the requirement for average voltage (common mode voltage) to be between 100 and 400 mV. [Figure 24](#) shows the SerDes reference clock input requirement for the DC-coupled connection scheme.
- For external AC-coupled connection, there is no common mode voltage requirement for the clock driver. Since the external AC-coupling capacitor blocks the DC level, the clock driver and the SerDes reference clock receiver operate in different command mode voltages. The SerDes reference clock receiver in this connection scheme has its common mode voltage set to $XCOREV_{SS}$. Each signal wire of the differential inputs is allowed to swing below and above the command mode voltage ($XCOREV_{SS}$). [Figure 25](#) shows the SerDes reference clock input requirement for AC-coupled connection scheme.
- Single-ended mode
 - The reference clock can also be single-ended. The SD_REF_CLK input amplitude (single-ended swing) must be between 400 and 800 mV peak-to-peak (from V_{min} to V_{max}) with SD_REF_CLK either left unconnected or tied to ground.
 - The SD_REF_CLK input average voltage must be between 200 and 400 mV. [Figure 26](#) shows the SerDes reference clock input requirement for the single-ended signaling mode.
 - To meet the input amplitude requirement, the reference clock inputs might need to be DC or AC coupled externally. For the best noise performance, the reference of the clock could be DC or AC coupled into the unused phase (SD_REF_CLK) through the same source impedance as the clock input (SD_REF_CLK) in use.

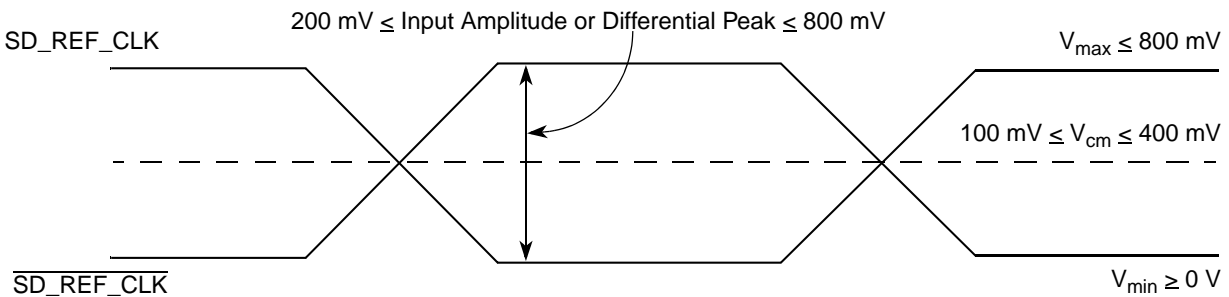


Figure 24. Differential Reference Clock Input DC Requirements (External DC-Coupled)

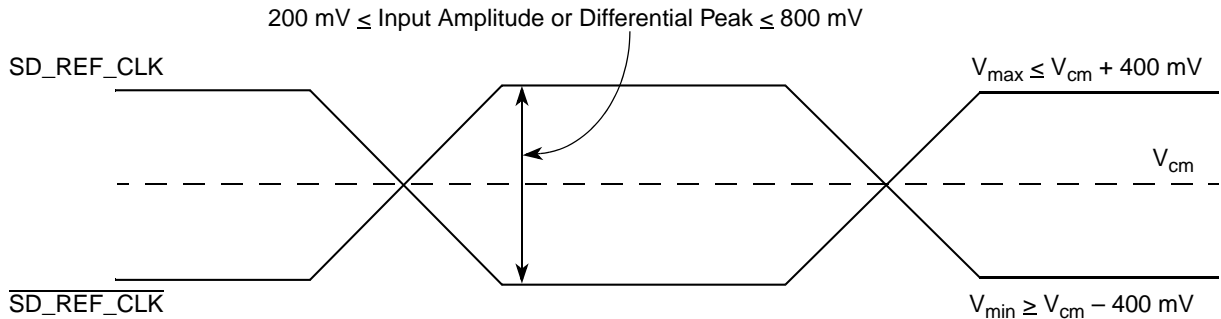


Figure 25. Differential Reference Clock Input DC Requirements (External AC-Coupled)

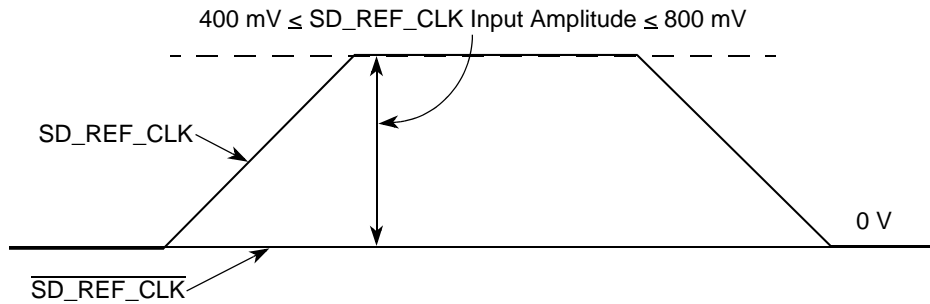


Figure 26. Single-Ended Reference Clock Input DC Requirements

9.2.3 Interfacing With Other Differential Signaling Levels

- With on-chip termination to $XCOREV_{SS}$, the differential reference clocks inputs are HCSL (high-speed current steering logic) compatible DC coupled.
- Many other low voltage differential type outputs like LVDS (low voltage differential signaling) can be used but may need to be AC coupled due to the limited common mode input range allowed (100 to 400 mV) for DC-coupled connection.
- LVPECL outputs can produce a signal with too large of an amplitude and may need to be DC-biased at the clock driver output first, then followed with series attenuation resistor to reduce the amplitude, in addition to AC coupling.

NOTE

Figure 27 through Figure 30 are for conceptual reference only. Due to the fact that the clock driver chip's internal structure, output impedance, and termination requirements are different between various clock driver chip manufacturers, it is possible that the clock circuit reference designs provided by clock driver chip vendors are different from what is shown in the figures. They might also vary from one vendor to the other. Therefore, Freescale can neither provide the optimal clock driver reference circuits, nor guarantee the correctness of the following clock driver connection reference circuits. It is recommended that the system designer contact the selected clock driver chip vendor for the optimal reference circuits for the MPC8313E SerDes reference clock receiver requirement provided in this document.

assumes that the LVPECL clock driver's output impedance is $50\ \Omega$. R1 is used to DC-bias the LVPECL outputs prior to AC coupling. Its value could be ranged from 140 to $240\ \Omega$ depending on the clock driver vendor's requirement. R2 is used together with the SerDes reference clock receiver's $50\text{-}\Omega$ termination resistor to attenuate the LVPECL output's differential peak level such that it meets the MPC8313E SerDes3 reference clock's differential input amplitude requirement (between 200 and $800\ \text{mV}$ differential peak). For example, if the LVPECL output's differential peak is $900\ \text{mV}$ and the desired SerDes reference clock input amplitude is selected as $600\ \text{mV}$, the attenuation factor is 0.67 , which requires $R2 = 25\ \Omega$. Consult with the clock driver chip manufacturer to verify whether this connection scheme is compatible with a particular clock driver chip.

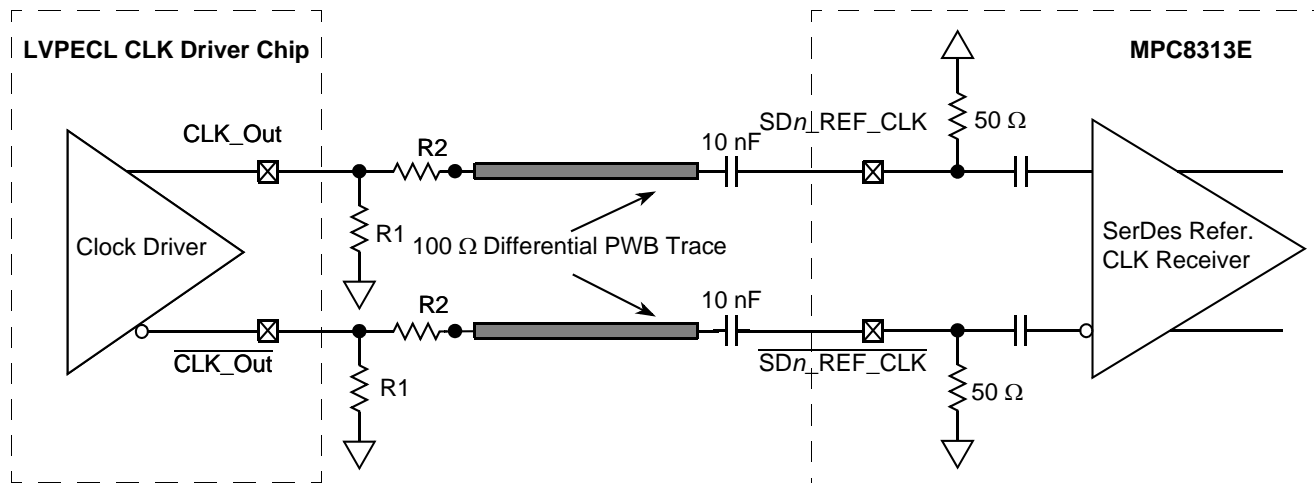


Figure 29. AC-Coupled Differential Connection with LVPECL Clock Driver (Reference Only)

This figure shows the SerDes reference clock connection reference circuits for a single-ended clock driver. It assumes the DC levels of the clock driver are compatible with the MPC8313E SerDes reference clock input's DC requirement.

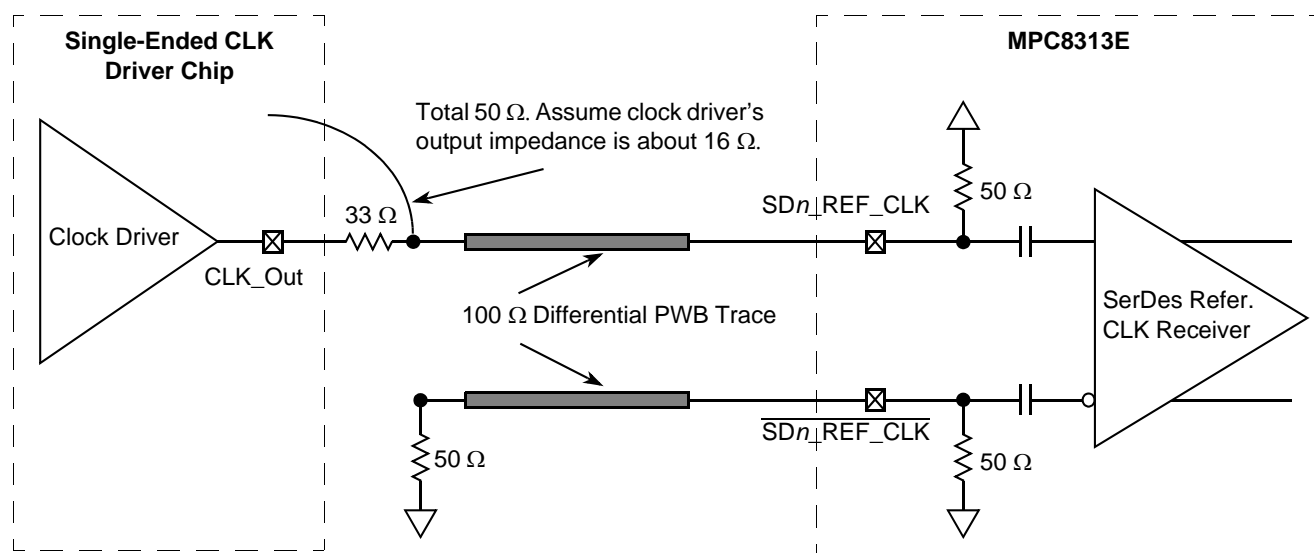


Figure 30. Single-Ended Connection (Reference Only)

9.2.4 AC Requirements for SerDes Reference Clocks

The clock driver selected should provide a high quality reference clock with low-phase noise and cycle-to-cycle jitter. Phase noise less than 100 kHz can be tracked by the PLL and data recovery loops and is less of a problem. Phase noise above 15 MHz is filtered by the PLL. The most problematic phase noise occurs in the 1–15 MHz range. The source impedance of the clock driver should be 50 Ω to match the transmission line and reduce reflections which are a source of noise to the system.

This table describes some AC parameters for SGMII protocol.

Table 39. SerDes Reference Clock Common AC Parameters

At recommended operating conditions with XV_{DD_SRDS1} or $XV_{DD_SRDS2} = 1.0\text{ V} \pm 5\%$.

Parameter	Symbol	Min	Max	Unit	Note
Rising edge rate	Rise edge rate	1.0	4.0	V/ns	2, 3
Falling edge rate	Fall edge rate	1.0	4.0	V/ns	2, 3
Differential input high voltage	V_{IH}	+200	—	mV	2
Differential input low voltage	V_{IL}	—	-200	mV	2
Rising edge rate (SDn_REF_CLK) to falling edge rate ($\overline{SDn_REF_CLK}$) matching	Rise-fall matching	—	20	%	1, 4

Notes:

1. Measurement taken from single-ended waveform.
2. Measurement taken from differential waveform.
3. Measured from -200 to +200 mV on the differential waveform (derived from SDn_REF_CLK minus $\overline{SDn_REF_CLK}$). The signal must be monotonic through the measurement region for rise and fall time. The 400 mV measurement window is centered on the differential zero crossing. See [Figure 31](#).
4. Matching applies to rising edge rate for SDn_REF_CLK and falling edge rate for $\overline{SDn_REF_CLK}$. It is measured using a 200 mV window centered on the median cross point, where SDn_REF_CLK rising meets $\overline{SDn_REF_CLK}$ falling. The median cross point is used to calculate the voltage thresholds the oscilloscope is to use for the edge rate calculations. The rise edge rate of SDn_REF_CLK should be compared to the fall edge rate of $\overline{SDn_REF_CLK}$, the maximum allowed difference should not exceed 20% of the slowest edge rate. See [Figure 32](#).



Figure 31. Differential Measurement Points for Rise and Fall Time

This figure provides the boundary-scan timing diagram.

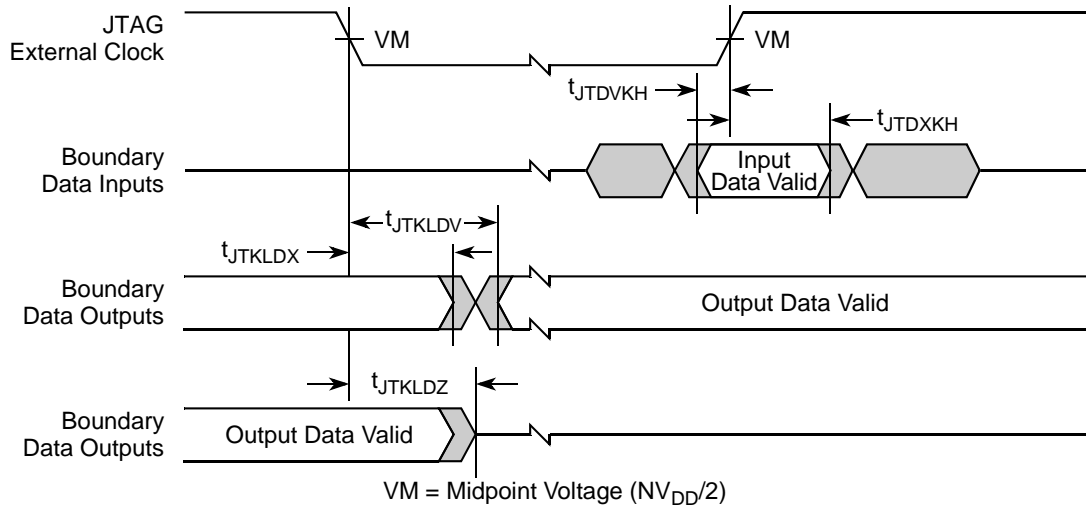


Figure 44. Boundary-Scan Timing Diagram

This figure provides the test access port timing diagram.

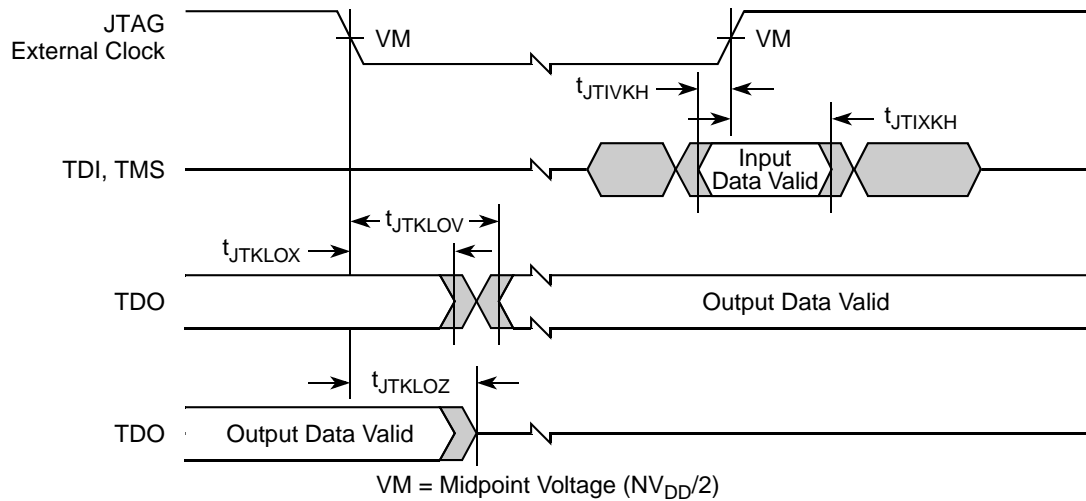


Figure 45. Test Access Port Timing Diagram

13 I²C

This section describes the DC and AC electrical characteristics for the I²C interface.

13.1 I²C DC Electrical Characteristics

This table provides the DC electrical characteristics for the I²C interface.

Table 48. I²C DC Electrical Characteristics

At recommended operating conditions with NV_{DD} of 3.3 V ± 0.3 V.

Parameter	Symbol	Min	Max	Unit	Note
Input high voltage level	V _{IH}	0.7 × NV _{DD}	NV _{DD} + 0.3	V	
Input low voltage level	V _{IL}	-0.3	0.3 × NV _{DD}	V	
Low level output voltage	V _{OL}	0	0.2 × NV _{DD}	V	1
Output fall time from V _{IH} (min) to V _{IL} (max) with a bus capacitance from 10 to 400 pF	t _{12KLV}	20 + 0.1 × C _B	250	ns	2
Pulse width of spikes which must be suppressed by the input filter	t _{12KHKL}	0	50	ns	3
Capacitance for each I/O pin	C _I	—	10	pF	
Input current, (0 V ≤ V _{IN} ≤ NV _{DD})	I _{IN}	—	± 5	μA	4

Notes:

1. Output voltage (open drain or open collector) condition = 3 mA sink current.
2. C_B = capacitance of one bus line in pF.
3. Refer to the *MPC8313E PowerQUICC II Pro Integrated Processor Family Reference Manual*, for information on the digital filter used.
4. I/O pins obstruct the SDA and SCL lines if NV_{DD} is switched off.

13.2 I²C AC Electrical Specifications

This table provides the AC timing parameters for the I²C interface.

Table 49. I²C AC Electrical Specifications

All values refer to V_{IH} (min) and V_{IL} (max) levels (see Table 48).

Parameter	Symbol ¹	Min	Max	Unit
SCL clock frequency	f _{12C}	0	400	kHz
Low period of the SCL clock	t _{12CL}	1.3	—	μs
High period of the SCL clock	t _{12CH}	0.6	—	μs
Setup time for a repeated START condition	t _{12SVKH}	0.6	—	μs
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t _{12SXKL}	0.6	—	μs
Data setup time	t _{12DVKH}	100	—	ns

This figure shows the AC timing diagram for the I²C bus.

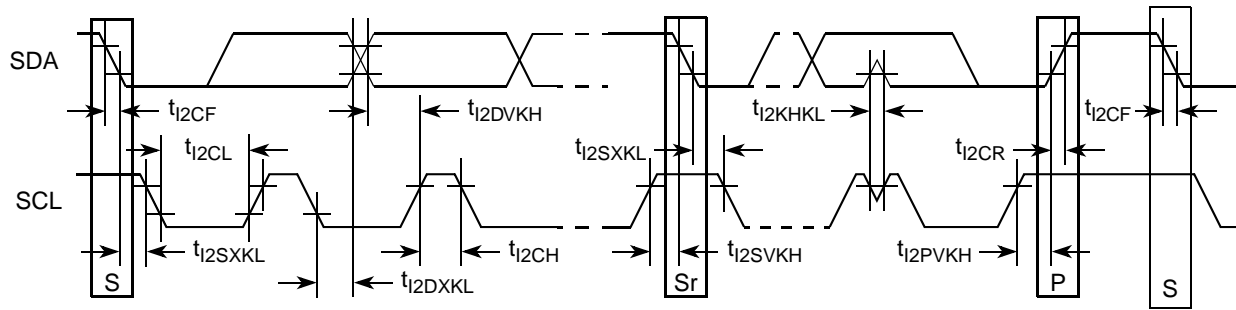


Figure 47. I²C Bus AC Timing Diagram

14 PCI

This section describes the DC and AC electrical specifications for the PCI bus.

14.1 PCI DC Electrical Characteristics

This table provides the DC electrical characteristics for the PCI interface.

Table 50. PCI DC Electrical Characteristics¹

Parameter	Symbol	Test Condition	Min	Max	Unit
High-level input voltage	V_{IH}	$V_{OUT} \geq V_{OH} (\text{min})$ or	$0.5 \times NV_{DD}$	$NV_{DD} + 0.3$	V
Low-level input voltage	V_{IL}	$V_{OUT} \leq V_{OL} (\text{max})$	-0.5	$0.3 \times NV_{DD}$	V
High-level output voltage	V_{OH}	$NV_{DD} = \text{min}, I_{OH} = -100 \mu\text{A}$	$0.9 \times NV_{DD}$	—	V
Low-level output voltage	V_{OL}	$NV_{DD} = \text{min}, I_{OL} = 100 \mu\text{A}$	—	$0.1 \times NV_{DD}$	V
Input current	I_{IN}	$0 \text{ V} \leq V_{IN} \leq NV_{DD}$	—	± 5	μA

Note:

- Note that the symbol V_{IN} , in this case, represents the NV_{IN} symbol referenced in [Table 1](#) and [Table 2](#).

14.2 PCI AC Electrical Specifications

This section describes the general AC timing parameters of the PCI bus. Note that the PCI_CLK or PCI_SYNC_IN signal is used as the PCI input clock depending on whether the MPC8313E is configured as a host or agent device.

This table shows the PCI AC timing specifications at 66 MHz.

Table 51. PCI AC Timing Specifications at 66 MHz

Parameter	Symbol ¹	Min	Max	Unit	Note
Clock to output valid	t_{PCKHOV}	—	6.0	ns	2
Output hold from clock	t_{PCKHOX}	1	—	ns	2

Table 51. PCI AC Timing Specifications at 66 MHz (continued)

Parameter	Symbol ¹	Min	Max	Unit	Note
Clock to output high impedance	t_{PCKHOZ}	—	14	ns	2, 3
Input setup to clock	t_{PCIVKH}	3.0	—	ns	2, 4
Input hold from clock	t_{PCIXKH}	0	—	ns	2, 4

Notes:

1. The symbols used for timing specifications follow the pattern of $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)(reference)(state)}$ for inputs and $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$ for outputs. For example, t_{PCIVKH} symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI_SYNC_IN clock, t_{SYS} , reference (K) going to the high (H) state or setup time. Also, t_{PCRHFV} symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
2. See the timing measurement conditions in the *PCI 2.3 Local Bus Specifications*.
3. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
4. Input timings are measured at the pin.

This table shows the PCI AC timing specifications at 33 MHz.

Table 52. PCI AC Timing Specifications at 33 MHz

Parameter	Symbol ¹	Min	Max	Unit	Note
Clock to output valid	t_{PCKHOV}	—	11	ns	2
Output hold from clock	t_{PCKHOX}	2	—	ns	2
Clock to output high impedance	t_{PCKHOZ}	—	14	ns	2, 3
Input setup to clock	t_{PCIVKH}	3.0	—	ns	2, 4
Input hold from clock	t_{PCIXKH}	0	—	ns	2, 4

Notes:

1. The symbols used for timing specifications follow the pattern of $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)(reference)(state)}$ for inputs and $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$ for outputs. For example, t_{PCIVKH} symbolizes PCI timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the PCI_SYNC_IN clock, t_{SYS} , reference (K) going to the high (H) state or setup time. Also, t_{PCRHFV} symbolizes PCI timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
2. See the timing measurement conditions in the *PCI 2.3 Local Bus Specifications*.
3. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
4. Input timings are measured at the pin.

This figure provides the AC test load for PCI.

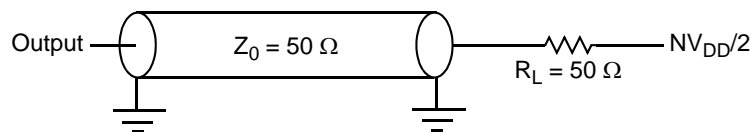


Figure 48. PCI AC Test Load

This figure shows the PCI input AC timing conditions.

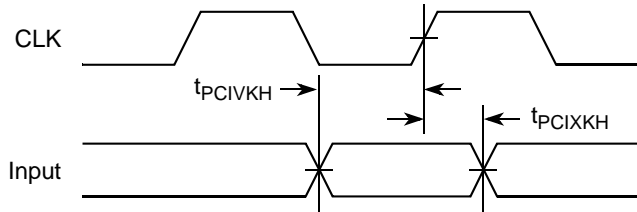


Figure 49. PCI Input AC Timing Measurement Conditions

This figure shows the PCI output AC timing conditions.

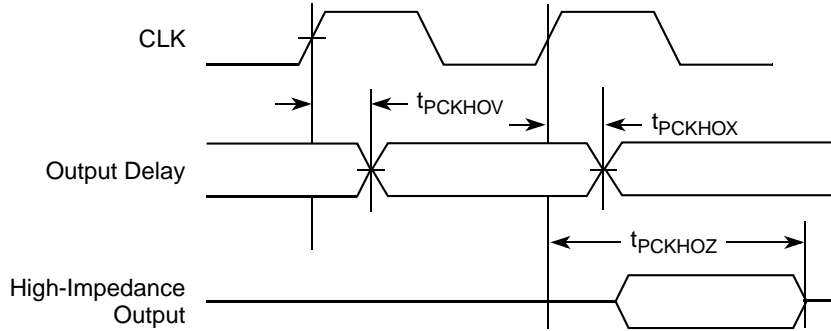


Figure 50. PCI Output AC Timing Measurement Condition

15 Timers

This section describes the DC and AC electrical specifications for the timers.

15.1 Timers DC Electrical Characteristics

This table provides the DC electrical characteristics for the MPC8313E timers pins, including \overline{TIN} , \overline{TOUT} , \overline{TGATE} , and RTC_CLK .

Table 53. Timers DC Electrical Characteristics

Characteristic	Symbol	Condition	Min	Max	Unit
Output high voltage	V_{OH}	$I_{OH} = -8.0 \text{ mA}$	2.4	—	V
Output low voltage	V_{OL}	$I_{OL} = 8.0 \text{ mA}$	—	0.5	V
Output low voltage	V_{OL}	$I_{OL} = 3.2 \text{ mA}$	—	0.4	V
Input high voltage	V_{IH}	—	2.1	$NV_{DD} + 0.3$	V
Input low voltage	V_{IL}	—	-0.3	0.8	V
Input current	I_{IN}	$0 \text{ V} \leq V_{IN} \leq NV_{DD}$	—	± 5	μA

Table 62. MPC8313E TEPBGAI Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Note
MEMC_MDQ29	A20	I/O	GV _{DD}	—
MEMC_MDQ30	C22	I/O	GV _{DD}	—
MEMC_MDQ31	B22	I/O	GV _{DD}	—
MEMC_MDM0	B7	O	GV _{DD}	—
MEMC_MDM1	E6	O	GV _{DD}	—
MEMC_MDM2	E18	O	GV _{DD}	—
MEMC_MDM3	E20	O	GV _{DD}	—
MEMC_MDQS0	A7	I/O	GV _{DD}	—
MEMC_MDQS1	E7	I/O	GV _{DD}	—
MEMC_MDQS2	B19	I/O	GV _{DD}	—
MEMC_MDQS3	A23	I/O	GV _{DD}	—
MEMC_MBA0	D15	O	GV _{DD}	—
MEMC_MBA1	A18	O	GV _{DD}	—
MEMC_MBA2	A15	O	GV _{DD}	—
MEMC_MA0	E12	O	GV _{DD}	—
MEMC_MA1	D11	O	GV _{DD}	—
MEMC_MA2	B11	O	GV _{DD}	—
MEMC_MA3	A11	O	GV _{DD}	—
MEMC_MA4	A12	O	GV _{DD}	—
MEMC_MA5	E13	O	GV _{DD}	—
MEMC_MA6	C12	O	GV _{DD}	—
MEMC_MA7	E14	O	GV _{DD}	—
MEMC_MA8	B15	O	GV _{DD}	—
MEMC_MA9	C17	O	GV _{DD}	—
MEMC_MA10	C13	O	GV _{DD}	—
MEMC_MA11	A16	O	GV _{DD}	—
MEMC_MA12	C15	O	GV _{DD}	—
MEMC_MA13	C16	O	GV _{DD}	—
MEMC_MA14	E15	O	GV _{DD}	—
MEMC_MWE	B18	O	GV _{DD}	—
MEMC_MRAS	C11	O	GV _{DD}	—
MEMC_MCAS	B10	O	GV _{DD}	—

Table 62. MPC8313E TEPBGAI Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Note
LA24	E23	O	LV _{DD}	11
LA25	D22	O	LV _{DD}	11
$\overline{\text{LCS0}}$	D23	O	LV _{DD}	10
$\overline{\text{LCS1}}$	J26	O	LV _{DD}	10
$\overline{\text{LCS2}}$	F22	O	LV _{DD}	10
$\overline{\text{LCS3}}$	D26	O	LV _{DD}	10
$\overline{\text{LWE0/LFWE}}$	E24	O	LV _{DD}	10
$\overline{\text{LWE1}}$	H26	O	LV _{DD}	10
LBCTL	L22	O	LV _{DD}	10
LALE/M1LALE/M2LALE	E26	O	LV _{DD}	11
LGPL0/LFCLE	AA23	O	LV _{DD}	—
LGPL1/LFALE	AA24	O	LV _{DD}	—
LGPL2/ $\overline{\text{LOE/LFRE}}$	AA25	O	LV _{DD}	10
LGPL3/ $\overline{\text{LFWP}}$	AA26	O	LV _{DD}	—
LGPL4/ $\overline{\text{LGTA/LUPWAIT/LFRB}}$	Y22	I/O	LV _{DD}	2
LGPL5	E21	O	LV _{DD}	10
LCLK0	H22	O	LV _{DD}	11
LCLK1	G26	O	LV _{DD}	11
LA0/GPIO0/MSRCID0	AC24	I/O	LV _{DD}	—
LA1/GPIO1/MSRCID1	Y24	I/O	LV _{DD}	—
LA2/GPIO2/MSRCID2	Y26	I/O	LV _{DD}	—
LA3/GPIO3/MSRCID3	W22	I/O	LV _{DD}	—
LA4/GPIO4/MSRCID4	W24	I/O	LV _{DD}	—
LA5/GPIO5/MDVAL	W26	I/O	LV _{DD}	—
LA6/GPIO6	V22	I/O	LV _{DD}	—
LA7/GPIO7/TSEC_1588_TRIG2	V23	I/O	LV _{DD}	8
LA8/GPIO13/TSEC_1588_ALARM1	V24	I/O	LV _{DD}	8
LA9/GPIO14/TSEC_1588_PP3	V25	I/O	LV _{DD}	8
LA10/TSEC_1588_CLK	V26	O	LV _{DD}	8
LA11/TSEC_1588_GCLK	U22	O	LV _{DD}	8
LA12/TSEC_1588_PP1	AD24	O	LV _{DD}	8
LA13/TSEC_1588_PP2	L25	O	LV _{DD}	8

Table 63. Configurable Clock Units

Unit	Default Frequency	Options
TSEC1	<i>csb_clk</i>	Off, <i>csb_clk</i> , <i>csb_clk/2</i> , <i>csb_clk/3</i>
TSEC2	<i>csb_clk</i>	Off, <i>csb_clk</i> , <i>csb_clk/2</i> , <i>csb_clk/3</i>
Security Core, I ² C, SAP, TPR	<i>csb_clk</i>	Off, <i>csb_clk</i> , <i>csb_clk/2</i> , <i>csb_clk/3</i>
USB DR	<i>csb_clk</i>	Off, <i>csb_clk</i> , <i>csb_clk/2</i> , <i>csb_clk/3</i>
PCI and DMA complex	<i>csb_clk</i>	Off, <i>csb_clk</i>

This table provides the operating frequencies for the MPC8313E TEPBGAI under recommended operating conditions (see [Table 2](#)).

Table 64. Operating Frequencies for TEPBGAI

Characteristic ¹	Maximum Operating Frequency	Unit
e300 core frequency (<i>core_clk</i>)	333	MHz
Coherent system bus frequency (<i>csb_clk</i>)	167	MHz
DDR1/2 memory bus frequency (MCK) ²	167	MHz
Local bus frequency (LCLK _n) ³	66	MHz
PCI input frequency (SYS_CLK_IN or PCI_CLK)	66	MHz

Note:

1. The SYS_CLK_IN frequency, RCWL[SPMF], and RCWL[COREPLL] settings must be chosen such that the resulting *csb_clk*, MCK, LCLK[0:1], and *core_clk* frequencies do not exceed their respective maximum or minimum operating frequencies. The value of SCCR[ENCCM] and SCCR[USBDRCM] must be programmed such that the maximum internal operating frequency of the security core and USB modules do not exceed their respective value listed in this table.
2. The DDR data rate is 2x the DDR memory bus frequency.
3. The local bus frequency is 1/2, 1/4, or 1/8 of the *lbc_clk* frequency (depending on LCRR[CLKDIV]), which is in turn, 1x or 2x the *csb_clk* frequency (depending on RCWL[LBCM]).

20.1 System PLL Configuration

The system PLL is controlled by the RCWL[SPMF] parameter. This table shows the multiplication factor encodings for the system PLL.

Table 65. System PLL Multiplication Factors

RCWL[SPMF]	System PLL Multiplication Factor
0000	Reserved
0001	Reserved
0010	× 2
0011	× 3

23.1 Part Numbers Fully Addressed by this Document

This table provides the Freescale part numbering nomenclature for the MPC8313E. Note that the individual part numbers correspond to a maximum processor core frequency. For available frequencies, contact your local Freescale sales office. In addition to the processor frequency, the part numbering scheme also includes an application modifier which may specify special application conditions. Each part number also contains a revision code which refers to the die mask revision number.

Table 72. Part Numbering Nomenclature

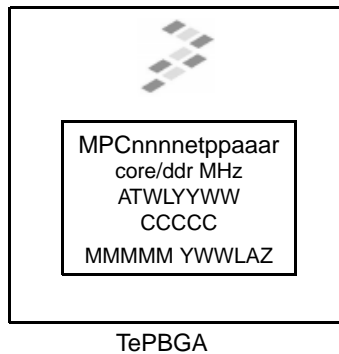
MPC	nnnn	e	t	pp	aa	a	x
Product Code	Part Identifier	Encryption Acceleration	Temperature Range ³	Package ^{1, 4}	e300 core Frequency ²	DDR Frequency	Revision Level
MPC	8313	Blank = Not included E = included	Blank = 0° to 105°C C = -40° to 105°C	ZQ = PB TEPBGAII VR = PB free TEPBGAII	AD = 266 MHz AF = 333 MHz AG = 400 MHz	D = 266 MHz F = 333 MHz	Blank = 1.0 A = 2.0 B = 2.1 C = 2.2

Note:

1. See [Section 19, "Package and Pin Listings,"](#) for more information on available package types.
2. Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by Part Number Specifications may support other maximum core frequencies.
3. Contact local Freescale office on availability of parts with °C temperature range.
4. ZQ package was available for Rev 1.0. For Rev 2.x, only VR package is available.

23.2 Part Marking

Parts are marked as shown in this figure.



Notes:

- MPCnnnnnetppaar is the orderable part number.
- ATWLYYWW is the standard assembly, test, year, and work week codes.
- CCCCC is the country code.
- MMMMM is the mask number.

Figure 62. Part Marking for TEPBGAII Device

Table 73. Document Revision History (continued)

Rev. Number	Date	Substantive Change(s)
1	3/2008	<ul style="list-style-type: none"> • In Table 63, added LBC_PM_REF_10 & LSRCID3 as muxed with USBDR_PCTL1 • In Table 63, added LSRCID2 as muxed with USBDR_PCTL0 • In Table 63, added LSRCID1 as muxed with USBDR_PWRFAULT • In Table 63, added LSRCID0 as muxed with USBDR_DRIVE_VBUS • In Table 63, moved T1, U2, & V2 from V_{DD} to XCOREVDD. • In Table 63, moved P2, R2, & T3 from V_{SS} to XCOREVSS. • In Table 63, moved P5, & U4 from V_{DD} to XPADVDD. • In Table 63, moved P3, & V4 from V_{SS} to XPADVSS. • In Table 63, removed “Double with pad” for AV_{DD1} and AV_{DD2} and moved AV_{DD1} and AV_{DD2} to Power and Ground Supplies section • In Table 63, added impedance control requirements for SD_IMP_CAL_TX (100 ohms to GND) and SD_IMP_CAL_RX (200 ohms to GND). • In Table 63, updated muxing in pinout to show new options for selecting IEEE 1588 functionality. Added footnote 8 • In Table 63, updated muxing in pinout to show new LBC ECC boot enable control muxed with eTSEC1_MDC • Added pin type information for power supplies. • Removed N1 and N3 from Vss section of Table 63. Added Therm0 and Therm1 (N1 and N3, respectively). Added note 7 to state: “Internal thermally sensitive resistor, resistor value varies linearly with temperature. Useful for determining the junction temperature.” • In Table 65 corrected maximum frequency of Local Bus Frequency from “33–66” to 66 MHz • In Table 65 corrected maximum frequency of PCI from “24–66” to 66 MHz • Added “which is determined by RCWLR[COREPLL],” to the note in Section 20.2, “Core PLL Configuration” about the VCO divider. • Added “(VCOD)” next to VCO divider column in Table 68. Added footnote stating that core_clk frequency must not exceed its maximum, so 2.5:1 and 3:1 core_clk:csb_clk ratios are invalid for certain csb_clk values. • In Table 69, notes were confusing. Added note 3 for VCO column, note 4 for CSB (csb_clk) column, note 5 for USB ref column, and note 6 to replace “Note 1”. Clarified note 4 to explain erratum eTSEC40. • In Table 69, updated note 6 to specify USB reference clock frequencies limited to 24 and 48 for rev. 2 silicon. • Replaced Table 71 “Thermal Resistance for TEPBGAll with Heat Sink in Open Flow”. • Removed last row of Table 19. • Removed 200 MHz rows from Table 21 and Table 5. • Changed VIH minimum spec from 2.0 to 2.1 for clock, PIC, JTAG, SPI, and reset pins in Table 9, Table 47, Table 54, Table 59, and Table 61. • Added Figure 4 showing the DDR input timing diagram. • In Table 19, removed “MDM” from the “MDQS-MDQ/MECC/MDM” text under the Parameter column for the tCISKEW parameter. MDM is an output signal and should be removed from the input AC timing spec table (tCISKEW). • Added “and power” to rows 2 and 3 in Table 10 • Added the sentence “Once both the power supplies...” and PORESET to Section 2.2, “Power Sequencing,” and Figure 3. • In Figure 35, corrected “USB0_CLK/USB1_CLK/DR_CLK” with “USBDR_CLK” • In Table 42, clarified that AC specs are for ULPI only.
0	6/2007	Initial release.